

MARK OFFICE
JUL 31 2003
Docket No.: 2000P15141

hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on the date indicated below.

By: 

Date: July 29, 2003

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Frank Pietzschmann
Applic. No. : 09/923,720
Filed : August 6, 2001
Title : Test Apparatus for Semiconductor Circuit and Method of Testing
Semiconductor Circuits
Examiner : Emily Y. Chan - Art Unit: 2829

INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. 1.97(C)(2)

Hon. Commissioner for Patents

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

German Published Non-Prosecuted Patent Application DE 198 53 445 A1
(Pietzschmann et al.), dated May 25, 2000, and English abstract thereof.

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant.

In accordance with 37 C.F.R. 1.97 (c) (2), consideration of this Information Disclosure Statement is requested.

08/01/2003 SSESHE1 00000119 09923720

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Enclosed is the fee in the amount of \$180.00.

Respectfully submitted,



For Applicant

Date: July 29, 2003

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FORM PTO-1449 (SUBSTITUTE)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEINFORMATION DISCLOSURE
STATEMENT BY APPLICANT
(37 CFR 1.98(b))Attorney Docket No.:
2000P15141Applic. No.
09/923,720

Applicant

Frank Pietzschmann

Filing Date
August 6, 2001Group Art Unit
2829

U.S. PATENT DOCUMENTS

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A						
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						

FOREIGN PATENT DOCUMENT

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J	198 53 445 A1	05/25/00	Germany			X
	K						
	L						
	M						
	N						

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	O	
	P	

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.